## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination PERNG ET AL. Examiner Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0038554	02-2004	Ahn et al.	438/778
	В	US-2003/0211748	11-2003	Jin et al.	438/709
	С	US-			
	D	US-			·
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-200275972	03-2002	JP	Arai et al	
	0					
	Φ					
	α					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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